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Form PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET PATENT AND TRADEMARK OFFICE LO29-016 LIST OF ART CITED BY APPLICANT APPLICANT Melzer et al. (Use several sheets if necessary) GROUP AU 2873 FILING DATE 04 U.S. PATENT DOCUMENTS Class Subclass Filing Date Date *Examiner Document Name If Appropriate Number Initial 4,195,913 04/80 Dourte et al. AΒ 4,277,141 07/81 Kleiber АC 4,389,115 06/83 Richter ΑD 6,166,868 12/00 Holderer et al. ΑE 4,038,971 08/77 Bezborodko Woolhouse et al. AF 4,236, 296 12/80 AG 4,740.276 04/88 Marmo et al. ΑH 5,891,317 04/99 Teichmann et al. Trunz et al. ΑI 6,369,959 04/02 6.503,383 01/03 Holderer et al. AJ 4,710,276 12/87 Kell ΑK 3,917,385 11/75 Caswell FOREIGN PATENT DOCUMENTS Document Country Class Subclass Translation Number Yes No WO99 66542 12/99 PCT DE 100 15 953 10/00 Germany ΑO WO86 05281 09/86 PCT ΑP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) Ellis, "Low-cost Bimorph Mirrors in Adaptice Optics," Imperial College of science, Technology & Medicine, University of London, 1999. AR Sato et al., Adaptive PVDF piezoelectric deformable mirror system," Applied Optics, Vol. 19, No. 9, 1980, pages 1430-1434. AS ΑT Sato et al., "Multilayered deformable mirror using PVDF films," Applied Optics, Vol. 21, No. 20, 1982, pages 3664-3668. DATE CONSIDERED 06 EXAMINER *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	Al	4,865,454	09/89	Lazzarini et al.					
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1	AB	6,411,426	06/02	Mechan et al.						
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